

DIFFERENTIAL BUS TRANSCEIVER

FEATURES

- **One-Fourth Unit Load Allows up to 128 Devices on a Bus**
- **ESD Protection for Bus Terminals:**
 - ± 15 -kV Human Body Model
 - ± 8 -kV IEC61000-4-2, Contact Discharge
 - ± 15 -kV IEC61000-4-2, Air-Gap Discharge
- **Meets or Exceeds the Requirements of ANSI Standard TIA/EIA-485-A and ISO 8482: 1987(E)**
- **Controlled Driver Output-Voltage Slew Rates Allow Longer Cable Stub Lengths**
- **Designed for Signaling Rates† Up to 250-kbps**
- **Low Disabled Supply Current . . . 250 μ A Max**
- **Thermal Shutdown Protection**
- **Open-Circuit Fail-Safe Receiver Design**
- **Receiver Input Hysteresis . . . 70 mV Typ**
- **Glitch-Free Power-Up and Power-Down Protection**

APPLICATIONS

- **Utility Meters**
- **Industrial Process Control**
- **Building Automation**

DESCRIPTION

The SN65LBC182 and SN75LBC182 are differential data line transceivers with a high level of ESD protection in the trade-standard footprint of the SN75176. They are designed for balanced transmission lines and meet ANSI standard TIA/EIA-485-A and ISO 8482. The SN65LBC182 and SN75LBC182 combine a 3-state, differential line driver and differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, which can be externally connected together to function as a direction control.

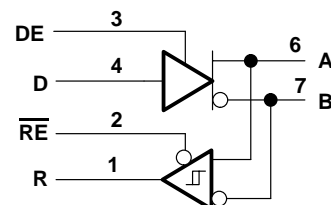
The driver outputs and the receiver inputs connect internally to form a differential input/output (I/O) bus port that is designed to offer minimum loading to the bus. This port operates over a wide range of common-mode voltage, making the device suitable for party-line applications. The device also includes additional features for party-line data buses in electrically noisy environment applications such as industrial process control or power inverters.

The SN75LBC182 and SN65LBC182 bus pins also exhibit a high input resistance equivalent to one-fourth unit load allowing connection of up to 128 similar devices on the bus. The high ESD tolerance protects the device for cabled connections. (For an even higher level of protection, see the SN65/75LBC184, literature number SLLS236.)

The differential driver design incorporates slew-rate-controlled outputs sufficient to transmit data up to 250 kbps. Slew-rate control allows longer unterminated cable runs and longer stub lengths from the main backbone than possible with uncontrolled voltage transitions. The receiver design provides a fail-safe output of a high level when the inputs are left floating (open circuit). Very low device supply current can be achieved by disabling the driver and the receiver.

The SN65LBC182 is characterized for operation from -40°C to 85°C , and the SN75LBC182 is characterized for operation from 0°C to 70°C .

functional block diagram



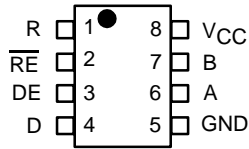
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†The signaling rate of a line, is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

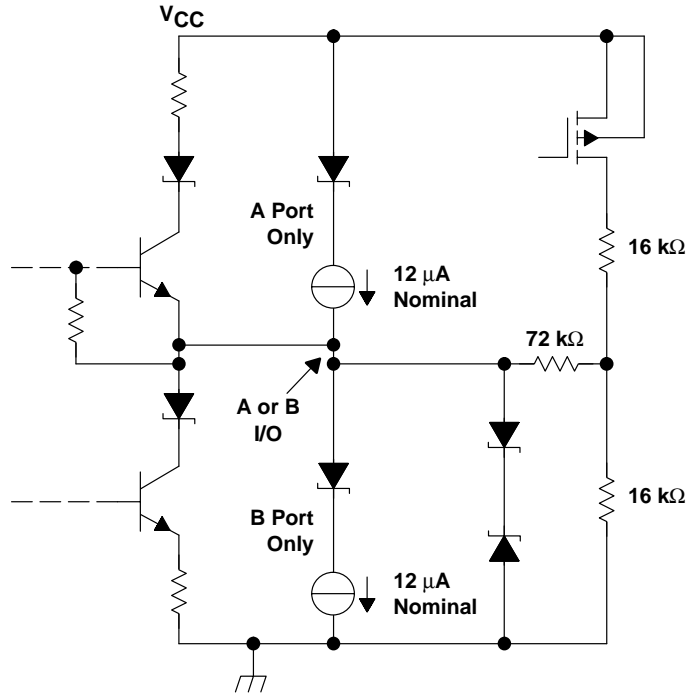
SN65LBC182 SN75LBC182

SLLS500 – MAY 2001

SN65LBC182D (Marked as 6LB182)
 SN75LBC182D (Marked as 7LB182)
 SN65LBC182P (Marked as 65LBC182)
 SN75LBC182P (Marked as 75LBC182)
 (TOP VIEW)



schematic of inputs and outputs



Function Tables

DRIVER

INPUT D	ENABLE DE	OUTPUTS	
		A	B
H	H	H	L
L	H	L	H
X	L	Z	Z
Open	H	H	L

RECEIVER

DIFFERENTIAL INPUTS	ENABLE RE	OUTPUT R
$V_{ID} \geq 0.2 \text{ V}$	L	H
$-0.2 \text{ V} < V_{ID} < 0.2 \text{ V}$	L	?
$V_{ID} \leq -0.2 \text{ V}$	L	L
X	H	Z
Open	L	H

AVAILABLE OPTIONS

T _A	PACKAGE	
	PLASTIC SMALL-OUTLINE† (JEDEC MS-012)	PLASTIC DUAL-IN-LINE PACKAGE (JEDEC MS-001)
0°C to 70°C	SN75LBC182D	SN75LBC182P
-40°C to 85°C	SN65LBC182D	SN65LBC182P

† Add R suffix for taped and reel.

driver electrical characteristics over recommended operating conditions

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V _{IK}	Input clamp voltage	I _I = -18 mA	-1.5			V
V _O	Output voltage	I _O = 0	0		V _{CC}	V
V _{OD}	Differential output voltage	R _L = 54 Ω, See Figure 1	1.5	2.2	V _{CC}	V
		V _{test} = -7 V to 12 V, See Figure 2	1.5	2.2	V _{CC}	V
ΔV _{OD}	Change in magnitude of differential output voltage	See Figure 1	-0.2		0.2	V
V _{OC(SS)}	Steady-state common-mode output voltage		1		3	
ΔV _{OC(SS)}	Change in steady-state common-mode output voltage		-0.2		0.2	
V _{OC(PP)}	Peak-to-peak change in common-mode output voltage during state transitions	See Figures 1 and 4		0.8		V
I _{OZ}	High-impedance output current	See receiver input currents				
I _{IH}	High-level input current (D, DE)	V _I = 2.4 V			50	μA
I _{IL}	Low-level input current (D, DE)	V _I = 0.4 V	-50			μA
I _{OS}	Short-circuit output current	V _O = -7 V to 12 V	-250		250	mA
I _{CC}	Supply current	SN75LBC182		12	25	mA
		SN65LBC182	No load, DE at V _{CC} , \overline{RE} at V _{CC}	12	30	

† All typical values are at V_{CC} = 5 V and T_A = 25°C.

driver switching characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _r	Differential output signal rise time	R _L = 54 Ω, C _L = 50 pF, See Figure 3	0.25	0.72	1.2	μs
t _f	Differential output signal fall time		0.25	0.73	1.2	
t _{PLH}	Propagation delay time, low-to-high-level output				1.3	
t _{PHL}	Propagation delay time, high-to-low-level output				1.3	
t _{sk(p)}	Pulse skew (t _{PHL} - t _{PLH})			0.075	0.15	
t _{PZH}	Output enable time to high level	R _L = 110 Ω, See Figure 5			3.5	μs
t _{PHZ}	Output disable time from high level				3.5	
t _{PZL}	Output enable time to low level	R _L = 110 Ω, See Figure 6			3.5	μs
t _{PLZ}	Output disable time from low level				3.5	

receiver electrical characteristics over recommended operating conditions (unless otherwise noted)

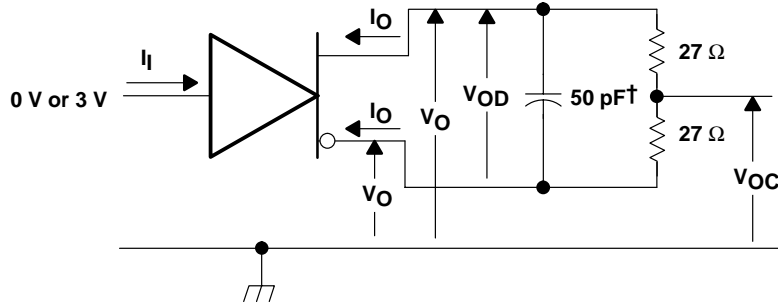
PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V_{IT+}	Positive-going input threshold voltage				0.2	V
V_{IT-}	Negative-going input threshold voltage		-0.2			
V_{hys}	Hysteresis voltage ($V_{IT+} - V_{IT-}$)			70		mV
V_{IK}	Enable-input clamp voltage	$I_I = -18$ mA	-1.5			V
V_{OH}	High-level output voltage	$V_{ID} = 200$ mV, $I_O = -8$ mA, See Figure 7	2.8			V
V_{OL}	Low-level output voltage	$V_{ID} = 200$ mV, $I_O = 4$ mA, See Figure 7			0.4	V
I_{OZ}	High-impedance-state output current	$V_O = 0.4$ to 2.4 V			± 1	μ A
I_I	Bus input current	$V_{IH} = 12$ V, $V_{CC} = 5$ V	Other input at 0 V		250	μ A
		$V_{IH} = 12$ V, $V_{CC} = 0$ V			250	
		$V_{IH} = -7$ V, $V_{CC} = 5$ V			-200	
		$V_{IH} = -7$ V, $V_{CC} = 0$ V			-200	
I_{IH}	High-level input current (\overline{RE})	$V_{IH} = 2$ V			50	μ A
I_{IL}	Low-level input current (\overline{RE})	$V_{IL} = 0.8$ V	-50			μ A
I_{CC}	Supply current	No load	DE at 0 V, \overline{RE} at 0 V		3.5	mA
			DE at 0 V, \overline{RE} at V_{CC}		175 250	μ A

† All typical values are at $V_{CC} = 5$ V and $T_A = 25^\circ$ C.

receiver switching characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_r	Differential output signal rise time	$C_L = 50$ pF, See Figure 7		20		ns
t_f	Differential output signal fall time			20		
t_{PLH}	Propagation delay time, low-to-high-level output				150	
t_{PHL}	Propagation delay time, high-to-low-level output				150	
t_{PZH}	Output enable time to high level	See Figure 8		100		ns
t_{PZL}	Output enable time to low level			100		
t_{PHZ}	Output disable time from high level				100	ns
t_{PLZ}	Output disable time from low level				100	
$t_{sk(p)}$	Pulse skew $ t_{PHL} - t_{PLH} $			50	ns	

PARAMETER MEASUREMENT INFORMATION



†Includes probe and jig capacitance

Figure 1. Driver Test Circuit, V_{OD} and V_{OC} Without Common-Mode Loading

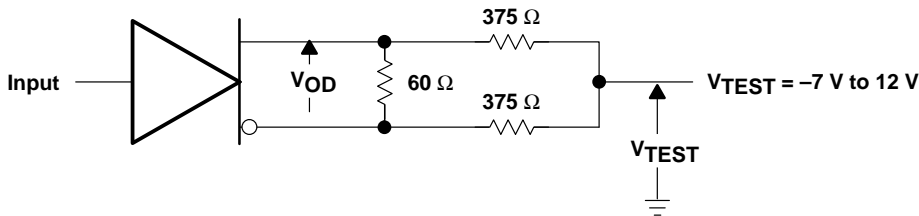
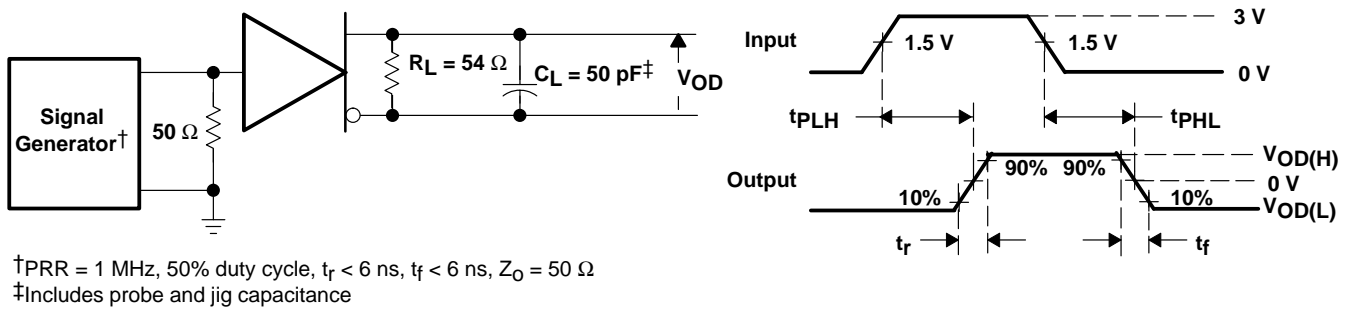


Figure 2. Driver Test Circuit, V_{OD} With Common-Mode Loading



†PRR = 1 MHz, 50% duty cycle, $t_r < 6$ ns, $t_f < 6$ ns, $Z_0 = 50 \Omega$

‡Includes probe and jig capacitance

Figure 3. Driver Switching Test Circuit and Waveforms

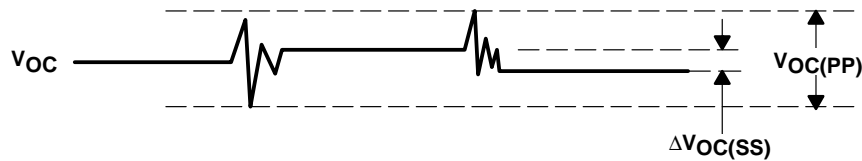
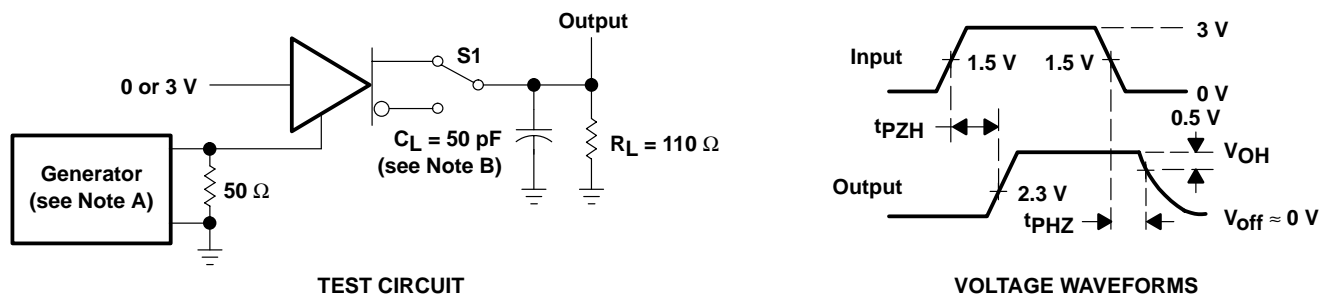


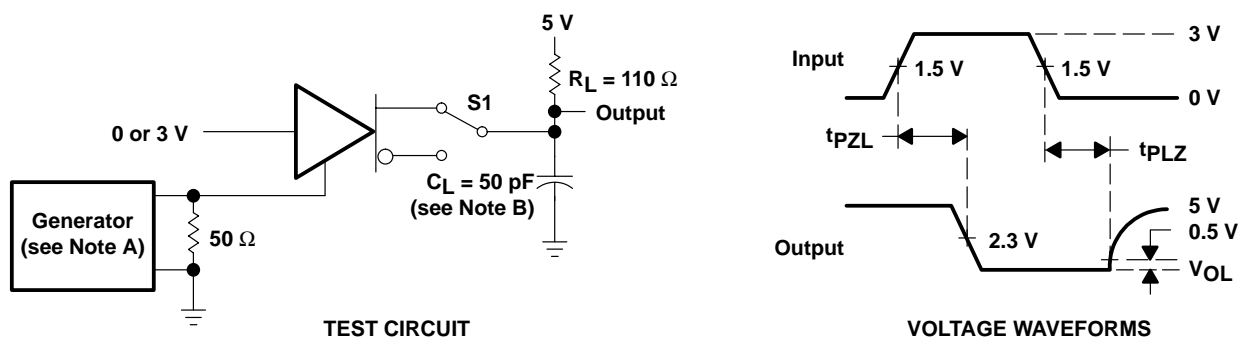
Figure 4. V_{OC} Definitions

PARAMETER MEASUREMENT INFORMATION



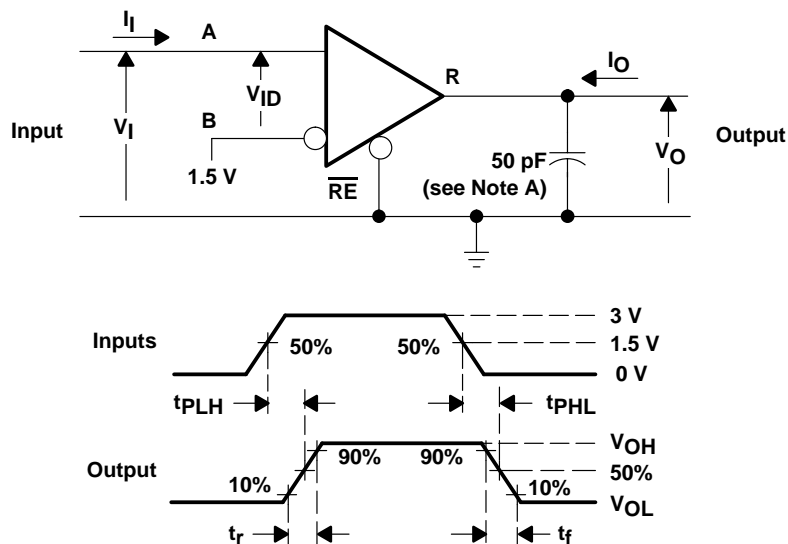
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR = 1.25 kHz, 50% duty cycle, $t_r \leq 10$ ns, $t_f \leq 10$ ns, $Z_O = 50 \Omega$.
B. C_L includes probe and jig capacitance.

Figure 5. Driver t_{pZH} and t_{pHZ} Test Circuit and Voltage Waveforms



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR = 1.25 kHz, 50% duty cycle, $t_r \leq 10$ ns, $t_f \leq 10$ ns, $Z_O = 50 \Omega$.
B. C_L includes probe and jig capacitance.

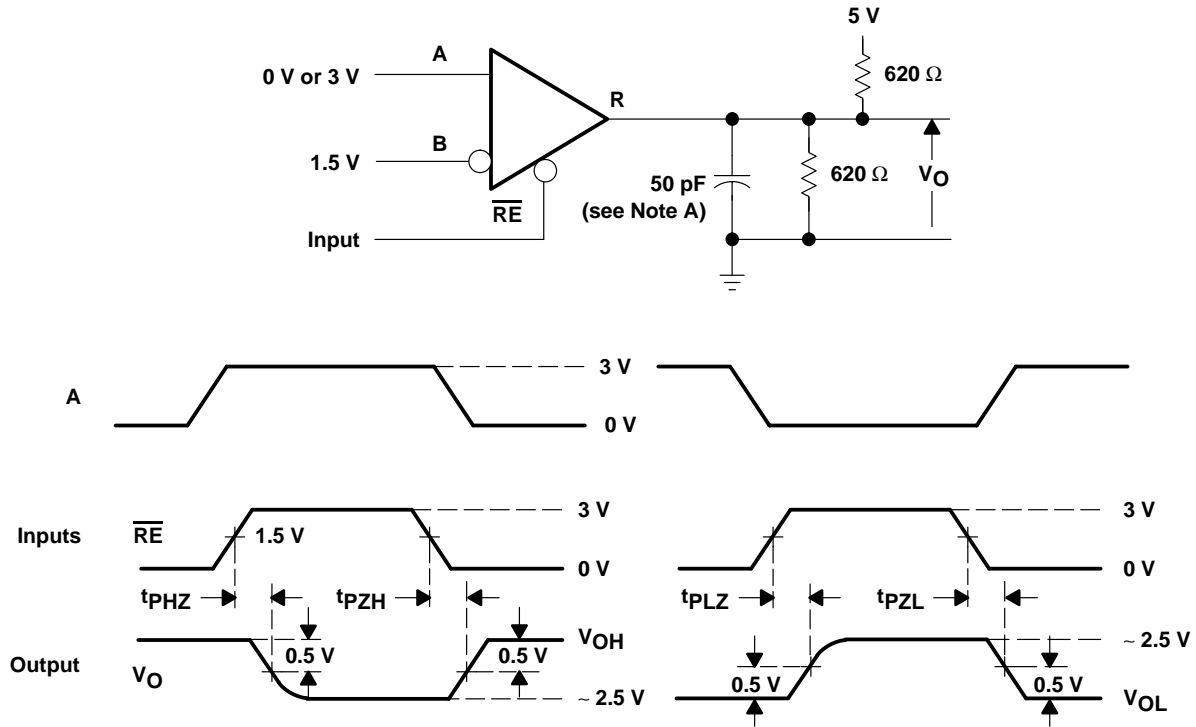
Figure 6. Driver t_{pZL} and t_{pLZ} Test Circuit and Voltage Waveforms



NOTE A: This value includes probe and jig capacitance ($\pm 10\%$).

Figure 7. Receiver t_{pLH} and t_{pHL} Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



NOTE A: This value includes probe and jig capacitance ($\pm 10\%$).

Figure 8. Receiver t_{PZL} , t_{PLZ} , t_{PZH} , and t_{PHZ} Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

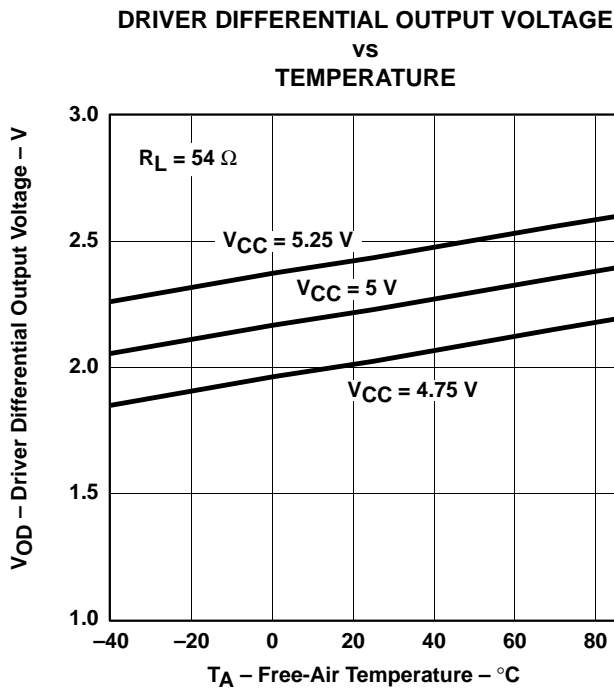


Figure 9

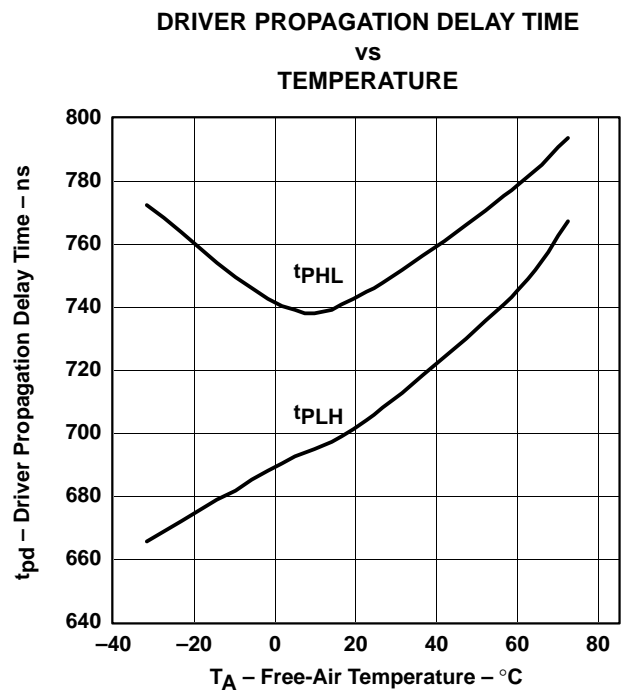


Figure 10

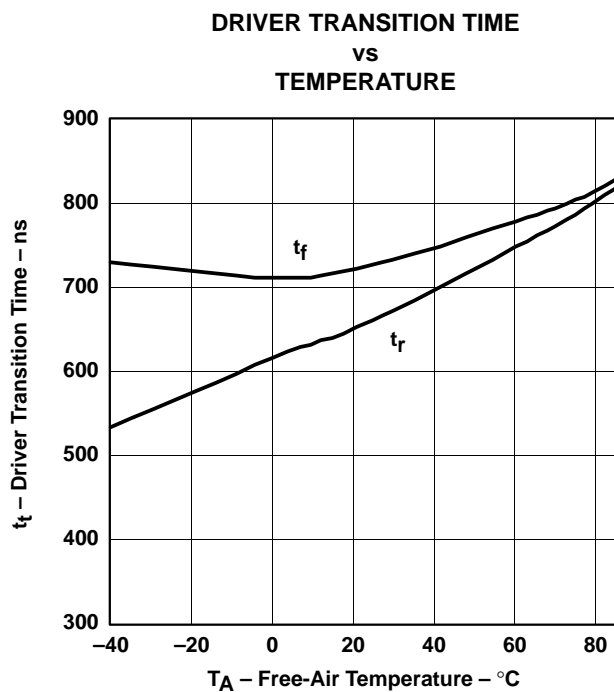


Figure 11

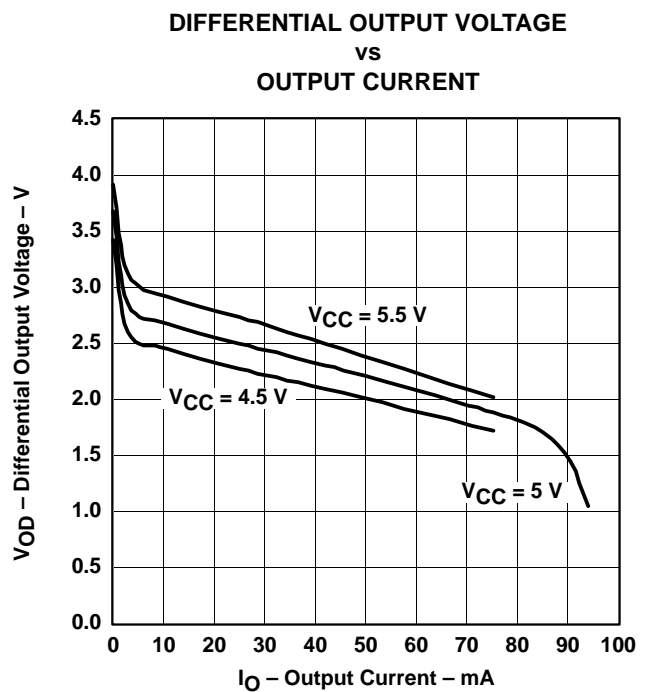


Figure 12

TYPICAL CHARACTERISTICS

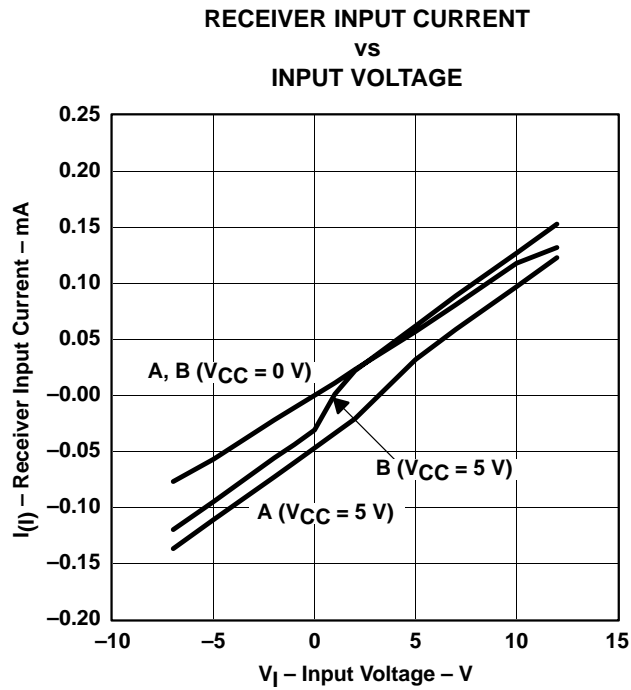
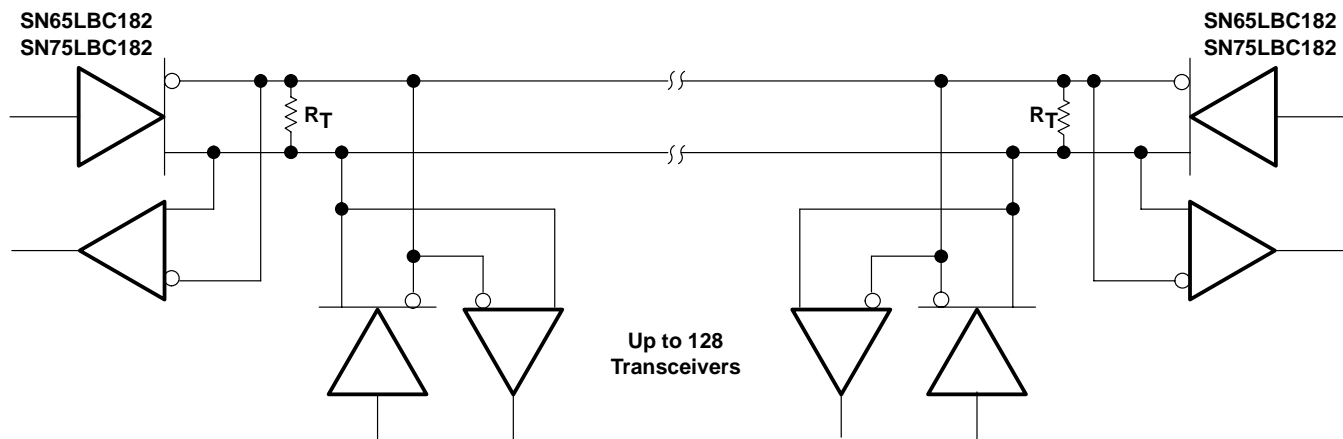


Figure 13

APPLICATION INFORMATION



NOTE A: The line should be terminated at both ends in its characteristic impedance ($R_T = Z_0$). Stub lengths off the main line should be kept as short as possible.

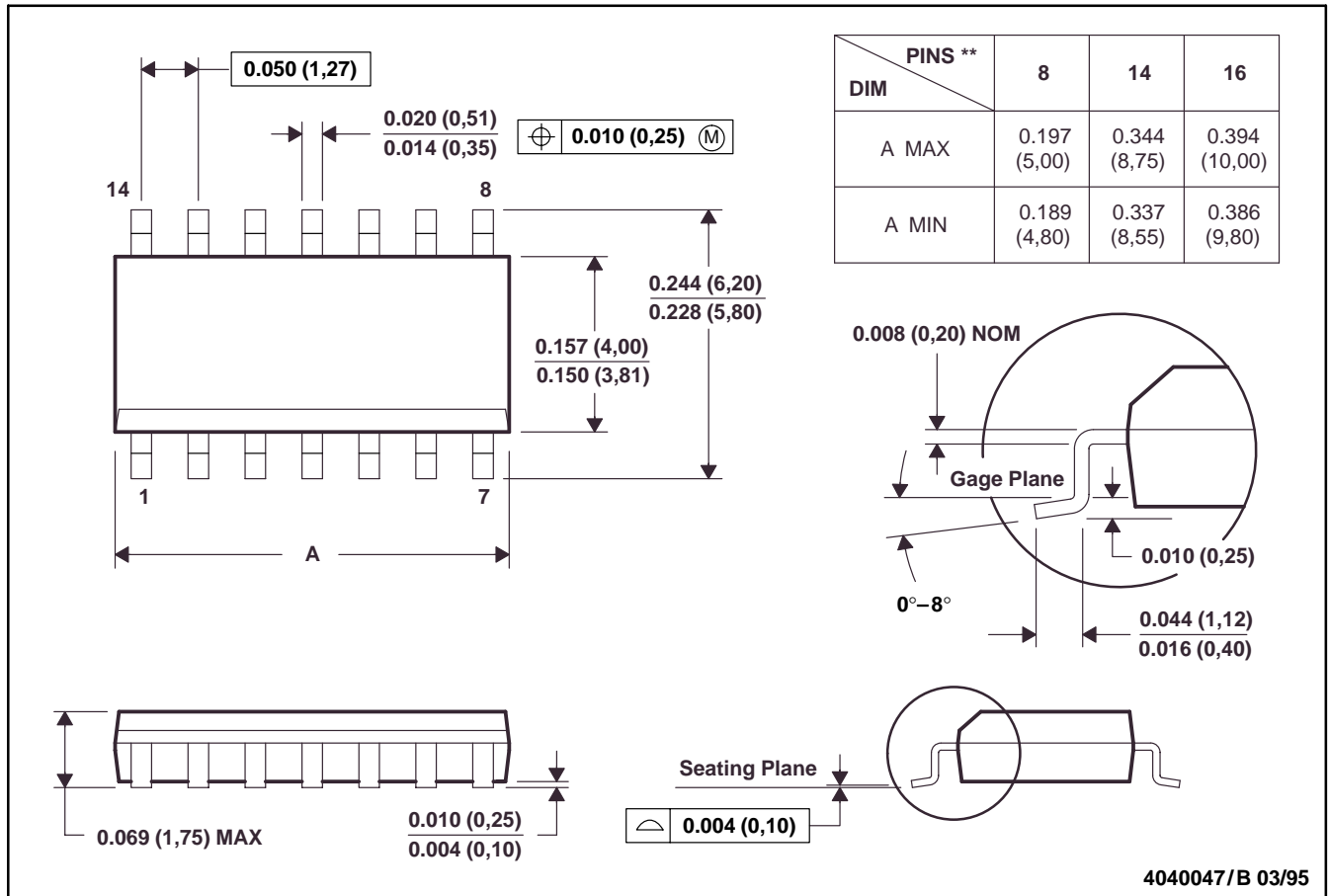
Figure 14. Typical Application Circuit

MECHANICAL INFORMATION

D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN

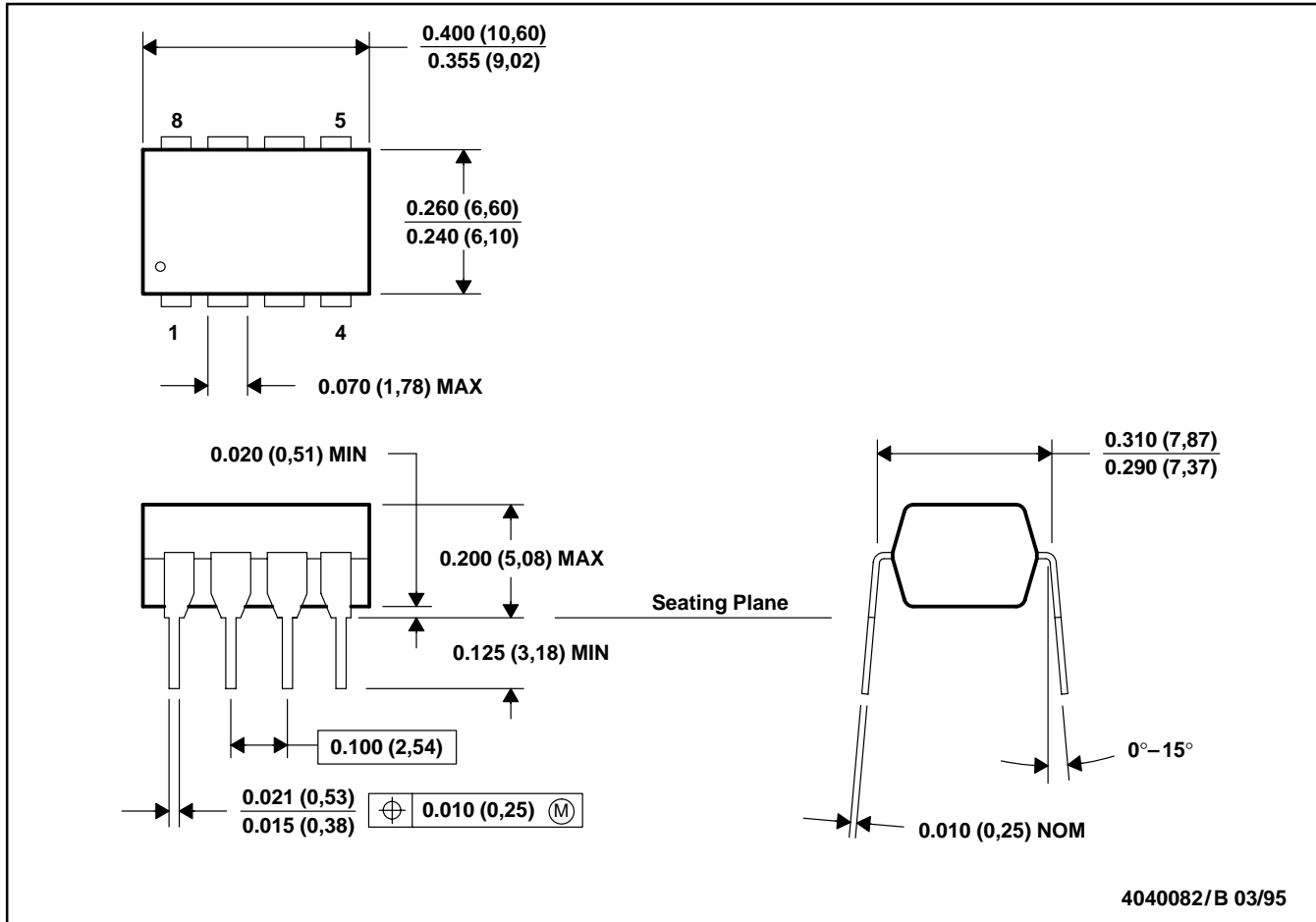


- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
 D. Four center pins are connected to die mount pad.
 E. Falls within JEDEC MS-012

MECHANICAL INFORMATION

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Falls within JEDEC MS-001

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